

Search Notes

Application/Control No.

10/788,709

Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

FOO ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	156,544, 147,150	5/9/2005	HLN
327	162,163		
713	320,323		
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331	1R,1A,18		
331	25,34		
331	DIG.2		
375	373,375		
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted with Minh Nguyen, Primary Examiner, AU # 2816	5/9/2005	HLN
Shepardize Search	5/11/2005	HLN